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Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/602,462	BEDELL ET AL.
Examiner	Art Unit
Tianiie Chen	2627

Subclass 126	Date	Examiner
247		
317	7/5/2007	TJ

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east Reports	7/5/2007	TJ